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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.		
10/749,885	12/31/2003	Kendall S. Wills	TI-37080 (032350.B576) 8899			
23494	7590 05/20/2005	05/20/2005		EXAMINER		
TEXAS INS	STRUMENTS INCORP	BHAT, ADITYA S				
	5474, M/S 3999	ART UNIT	PAPER NUMBER			
DALLAS, TX 75265			L	FAFER NUMBER		
			2863			
			DATE MAIL ED: 05/20/2009	DATE MAILED: 05/20/2005		

Please find below and/or attached an Office communication concerning this application or proceeding.

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		Application	n No.	Applicant(s)				
Office Action Summary		10/749,885	;	WILLS ET AL.				
		Examiner		Art Unit				
		Aditya S. B		2863				
To Period for R	he MAILING DATE of this communi eply	cation appears on the	cover sheet with the c	correspondence addr	ess			
THE MAI - Extension after SIX (- If the peric - If NO peric - Failure to Any reply	TENED STATUTORY PERIOD FOR LING DATE OF THIS COMMUNISTS of time may be available under the provisions (6) MONTHS from the mailing date of this commod for reply specified above is less than thirty (30 and for reply is specified above, the maximum state reply within the set or extended period for reply received by the Office later than three months attent term adjustment. See 37 CFR 1.704(b).	CATION. of 37 CFR 1.136(a). In no ever unication. b) days, a reply within the statut tutory period will apply and will will, by statute, cause the applic	nt, however, may a reply be tin tory minimum of thirty (30) day expire SIX (6) MONTHS from cation to become ABANDONE	nety filed s will be considered timely. the mailing date of this com. D (35 U.S.C. § 133).	munication.			
Status								
1)⊠ Re	sponsive to communication(s) file	d on <i>24 February 200</i>	4.					
•	This action is FINAL . 2b) This action is non-final.							
′=	Since this application is in condition for allowance except for formal matters, prosecution as to the merits is							
*	closed in accordance with the practice under Ex parte Quayle, 1935 C.D. 11, 453 O.G. 213.							
Disposition	of Claims							
4a) 5)□ Cla 6)⊠ Cla 7)□ Cla	aim(s) <u>1-20</u> is/are pending in the a Of the above claim(s) is/are aim(s) is/are allowed. aim(s) <u>1-20</u> is/are rejected. aim(s) is/are objected to. aim(s) are subject to restric	e withdrawn from con						
Application	Papers							
9) 🔲 The	e specification is objected to by the	e Examiner.						
10)⊠ The	10)⊠ The drawing(s) filed on <u>31 December 2003</u> is/are: a)⊠ accepted or b)□ objected to by the Examiner.							
Арј	Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).							
	placement drawing sheet(s) including e oath or declaration is objected to	· ·			• •			
Priority und	er 35 U.S.C. § 119							
a)	_	documents have been documents have been of the priority documen hal Bureau (PCT Rule	received. received in Applicati nts have been receive 17.2(a)).	on No ed in this National St	tage			
Attachment(s)								
	References Cited (PTO-892) Draftsperson's Patent Drawing Review (P		 Interview Summary Paper No(s)/Mail Date 					
3) 🔯 Information	on Disclosure Statement(s) (PTO-1449 or (s)/Mail Date <u>2/24/04</u> .	PTO/SB/08)	5) Notice of Informal P 6) Other:		52)			

U.S. Patent and Trademark Office PTOL-326 (Rev. 1-04) Art Unit: 2863

DETAILED ACTION

Claim Rejections - 35 USC § 102

1. The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

(e) the invention was described in (1) an application for patent, published under section 122(b), by another filed in the United States before the invention by the applicant for patent or (2) a patent granted on an application for patent by another filed in the United States before the invention by the applicant for patent, except that an international application filed under the treaty defined in section 351(a) shall have the effects for purposes of this subsection of an application filed in the United States only if the international application designated the United States and was published under Article 21(2) of such treaty in the English language.

Claims 1-5, 7-11,13-20 are rejected under 35 U.S.C. 102(e) as being anticipated by Bechhoefer et al. (USPUB 2004/0230383)

With regards to claim 1, Bechhoefer et al. (USPUB 2004/0230383) teaches a system for wavelet analysis of one or more signals to determine one or more characteristics of one or more anomalies in a wire, the system comprising:

a library of one or more reference wavelet analysis results that each correspond to one or more known anomalies having one or more known characteristics; (abstract) (page2 paragraph 0013) (112;figure 2) and

an analysis module(108;figure 2) operable to:

receive a first signal from a detector that has scanned a magnetic field from a wire comprising an anomaly, the first signal corresponding to a second signal used to generate the magnetic field; (page1 paragraph 0007)

calculate a wavelet analysis result from a wavelet analysis of the first signal, the wavelet analysis result corresponding to the second signal; (See figure 26 A)

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access the library(figure 2);

compare the wavelet analysis result with one or more reference wavelet analysis results;(1034d;figure 22B)

if the wavelet analysis result corresponds to one or more particular reference wavelet analysis results, indicate that the anomaly in the wire has one or more particular known characteristics of one or more particular known anomalies corresponding to the one or more particular reference wavelet analysis results; (page 10 paragraph 0089) and

if the wavelet analysis result does not correspond to one or more reference wavelet analysis results, indicate that the anomaly in the wire lacks one or more known characteristics of one or more known anomalies corresponding to one or more reference wavelet analysis results in the library. (Page 10, paragraph 0091)

With regards to claims 2,8, and 14, Bechhoefer et al. (USPUB 2004/0230383) teaches the wavelet analysis result comprises a wavelet power spectrum of the first signal and the reference wavelet analysis results each comprise one or more reference wavelet power spectra. (see figure 26 A)

With regards to claims 3, 9, and 15, Bechhoefer et al. (USPUB 2004/0230383) teaches a wavelet transform is used to calculate the wavelet power spectrum of the TDR signal. (Page 9, paragraph 0081) (See figure 25 & 26 A)

With regards to claims 4, 10, and 16 Bechhoefer et al. (USPUB 2004/0230383) teaches the second signal is a time domain reflectometry (TDR) signal. (Page 9, paragraph 0081) (See figure 25 & 26 A)

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With regards to claims 5, 11, and 17, Bechhoefer et al. (USPUB 2004/0230383) teaches a location of the anomaly is determined according to the scan of the magnetic field from the wire. (Page 24, paragraph 0256)

With regards to claim 7, Bechhoefer et al. (USPUB 2004/0230383) teaches a method for wavelet analysis of one or more signals to determine one or more characteristics of one or more anomalies in a wire, the method comprising:

receiving a first signal from a detector that has scanned a magnetic field from a wire comprising an anomaly, the first signal corresponding to a second signal used to generate the magnetic field; (page 1, paragraph 0007)

calculating a wavelet analysis result from a wavelet analysis of the first signal, the wavelet analysis result corresponding to the second signal; (page 3, paragraph 0013)

accessing a library of one or more reference wavelet analysis results that each correspond to one or more known anomalies having one or more known characteristics; (page 2 paragraph 0013) (112;figure 2)

comparing the wavelet analysis result with one or more reference wavelet analysis results; (page 6, paragraph 0026)

if the wavelet analysis result corresponds to one or more particular reference wavelet analysis results, indicating that the anomaly in the wire has one or more particular known characteristics of one or more particular known anomalies corresponding to the one or more particular reference wavelet analysis results; (Page 10, paragraph 0089) and

if the wavelet analysis result does not correspond to one or more reference wavelet analysis results, indicating that the anomaly in the wire lacks one or more known characteristics of one or more known anomalies corresponding to one or more reference wavelet analysis results in the library. (Page 10, paragraph 0091)

With regards to claim 13, Bechhoefer et al. (USPUB 2004/0230383) teaches software for wavelet analysis of one or more signals to determine one or more characteristics of one or more anomalies in a wire, the software embodied in computer-readable media and when executed operable to:

receive a first signal from a detector that has scanned a magnetic field from a wire comprising an anomaly, the first signal corresponding to a second signal used to generate the magnetic field; (page 1, paragraph 0007)

calculate a wavelet analysis result from a wavelet analysis of the first signal, the wavelet analysis result corresponding to the second signal; (page 3, paragraph 0013)

access a library of one or more reference wavelet analysis results that each correspond to one or more known anomalies having one or more known characteristics; (page 2 paragraph 0013) (112;figure 2)

compare the wavelet analysis result with one or more reference wavelet analysis results; (page 6, paragraph 0026)

if the wavelet analysis result corresponds to one or more particular reference wavelet analysis results, indicate that the anomaly in the wire has one or more particular known characteristics of one or more particular known anomalies corresponding to the

one or more particular reference wavelet analysis results; (Page 10, paragraph 0091)

if the wavelet analysis result does not correspond to one or more reference wavelet analysis results, indicate that the anomaly in the wire lacks one or more known characteristics of one or more known anomalies corresponding to one or more reference wavelet analysis results in the library. (Page 10, paragraph 0091)

With regards to claim 19,Bechhoefer et al. (USPUB 2004/0230383) teaches a system for wavelet analysis of one or more signals to determine one or more characteristics of one or more anomalies in a wire, the system comprising:

means for receiving a first signal from a detector that has scanned a magnetic field from a wire comprising an anomaly, the first signal corresponding to a second signal used to generate the magnetic field; (page 1, paragraph 0007)

means for calculating a wavelet analysis result from a wavelet analysis of the first signal, the wavelet analysis result corresponding to the second signal; (page 3, paragraph 0013)

means for accessing a library of one or more reference wavelet analysis results that each correspond to one or more known anomalies having one or more known characteristics; (page 2 paragraph 0013) (112;figure 2)

means for comparing the wavelet analysis result with one or more reference wavelet analysis results; (page 6, paragraph 0026)

means for, if the wavelet analysis result corresponds to one or more particular reference wavelet analysis results, indicating that the anomaly in the wire has one or

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more particular known characteristics of one or more particular known anomalies corresponding to the one or more particular reference wavelet analysis results; (Page 10, paragraph 0089) and

means for, if the wavelet analysis result does not correspond to one or more reference wavelet analysis results, indicating that the anomaly in the wire lacks one or more known characteristics of one or more known anomalies corresponding to one or more reference wavelet analysis results in the library. (Page 10, paragraph 0091)

With regards to claim 20, Bechhoefer et al. (USPUB 2004/0230383) teaches a system for wavelet analysis of one or more signals to determine one or more characteristics of one or more anomalies in a wire, the system comprising:

a library of one or more reference wavelet power spectra that each correspond to one or more known anomalies having one or more known characteristics; (figure 2) and an analysis module operable to:

receive a first signal from a detector that has scanned a magnetic field from a wire comprising an anomaly, the first signal corresponding to a second signal used to generate the magnetic field, the second signal being a time domain reflectometry (TDR) signal; (Page 9, paragraph 0081)

calculate a wavelet power spectrum of the first signal, the wavelet power spectrum corresponding to the second signal; (Page 3, paragraph 0013)

access the library;(figure 2)

compare the wavelet power spectrum with one or more reference wavelet power spectra; (figure 25-26A)

if the wavelet power spectrum corresponds to one or more particular reference wavelet power spectra, indicate that the anomaly in the wire has one or more particular known characteristics of one or more particular known anomalies corresponding to the one or more particular reference wavelet power spectra; (Page 2, paragraph 0013) and

if the wavelet analysis result does not correspond to one or more reference wavelet power spectra, indicate that the anomaly in the wire lacks one or more known characteristics of one or more known anomalies corresponding to one or more reference wavelet power spectra in the library. (Page 2, paragraph 0013)

Claim Rejections - 35 USC § 103

- 2. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
 - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

Claims 6,12 and 18 are rejected under 35 U.S.C. 103(a) as being unpatentable over Bechhoefer et al. (USPUB 2004/0230383).

With regards to claims 6, 12, and 18 Bechhoefer et al. (USPUB 2004/0230383) does not appear to explicitly disclose an integrated circuit (IC) package comprises the wire.

It would have been obvious to one skilled in the art at the time of the invention to test a wire that is included in a integrated circuit package, since, it has been held that a recitation with respect to the manner in which a claimed apparatus is intended to be Application/Control Number: 10/749,885 Page 9

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employed does not differentiate the claimed apparatus from a prior art apparatus satisfying the claimed structural limitations. Ex parte Masham, 2 USPQ2d-1647 (1987).

Conclusion

- 3. The prior art made of record and not relied upon is considered pertinent to applicant's disclosure. Ahuja et al. (USPN 5,740,036) teaches a method and apparatus for analyzing geological data using wavelet analysis, Guigne (USPN 4924449) teaches an acoustic sub-surface interrogator, Yamamoto (USPN 5,243,565) teaches a method of measuring direction spectra of surface gravity waves and Huang (USPN 6,311,130) teaches a computer implemented empirical mode decomposition method, apparatus, and article of manufacture for two-dimensional signals
- 4. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Aditya S. Bhat whose telephone number is 571-272-2270. The examiner can normally be reached on M-F 9-5:30.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, John Barlow can be reached on 571-272-2269. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should

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you have questions on access to the Private PAIR system, contact the Electronic

Business Center (EBC) at 866-217-9197 (toll-free).

Aditya Bhat May 11,2005

John Barjow Siyuervisory Patent Examiner Technology Center 2800

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